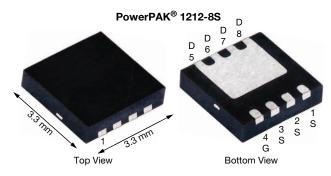
# SiSS98DN

www.vishay.com

**Vishay Siliconix** 

# N-Channel 200 V (D-S) MOSFET

PRODU	CT SUMMARY		
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) (MAX.)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (TYP.)
200	0.105 at V <sub>GS</sub> = 10 V	14.1	9.3 nC
	0.110 at V <sub>GS</sub> = 7.5 V	13.8	9.5 110

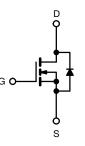


#### **FEATURES**

- ThunderFET<sup>®</sup> power MOSFET
- Optimized Q<sub>g</sub> and Q<sub>oss</sub> improve efficiency
- 100 % R<sub>q</sub> and UIS tested
- FREE · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

#### **APPLICATIONS**

- Primary side switching
- Synchronous rectification
- DC/DC converters
- Boost converters



N-Channel MOSFET

**Ordering Information:** 

SiSS98DN-T1-GE3 (lead (Pb)-free and halogen-free)

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	200	N/	
Gate-Source Voltage		V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		14.1		
	T <sub>C</sub> = 70 °C		11.2		
Continuous Drain Current ( $T_J = 150 \ ^\circ C$ )	T <sub>A</sub> = 25 °C	I <sub>D</sub>	4.1 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		3.2 <sup>b, c</sup>		
Pulsed Drain Current (t = 100 µs)		I <sub>DM</sub>	30	- A	
Continuous Courses Durin Diada Courset	T <sub>C</sub> = 25 °C		14.1		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	4.3 <sup>b, c</sup>		
Single Pulse Avalanche Current		I <sub>AS</sub>	10		
Single Pulse Avalanche Energy L = 0.1 mH		E <sub>AS</sub>	5	mJ	
	T <sub>C</sub> = 25 °C		57		
Mauinum Daura Disainatian	T <sub>C</sub> = 70 °C		36	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	4.8 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		3 b, c		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150		
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>		-	260		

### THERMAL RESISTANCE BATINGS

PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum Junction-to-Ambient b, f	t ≤ 10 s	R <sub>thJA</sub>	21	26	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	1.7	2.2	0/10

#### Notes

a. Based on  $T_C = 25$  °C.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. See solder profile (<u>www.vishay.com/doc?73257</u>). The PowerPAK 1212-8S is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions is 70 °C/W.

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COMPLIANT

HALOGEN

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## SiSS98DN

Vishay Siliconix

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static	цц					•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	200	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	L 050A	-	186	-	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-6	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	-	4	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V},  V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zaura Oasta Malta era Durain Orumant		$V_{DS} = 200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	1	
Zero Gate Voltage Drain Current	IDSS	V= 200 V, $V_{DS GS}$ = 0 V, $T_{J}$ = 70 °C	-	-	10	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	15	-	-	А
	P	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 7 \text{ A}$	-	0.085	0.105	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 7.5 \text{ V}, \text{ I}_{D} = 7 \text{ A}$	-	0.089	0.110	Ω
Forward Transconductance a	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 7 \text{ A}$	-	16.5	-	S
Dynamic <sup>b</sup>					•	
Input Capacitance	C <sub>iss</sub>		-	608	-	pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$	-	57	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	7	-	
Tabal Oaks Observe		$V = 100 V, V_{GS} = 10 V, I_D = 3 A$	-	12.1	18.2	
Total Gate Charge	Qg		-	9.3	14	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = 100 V, $V_{GS}$ = 7.5 V, $I_{D}$ = 3 A	-	2.9	-	nC
Gate-Drain Charge	Q <sub>gd</sub>		-	2.9	-	
Output Charge	Q <sub>oss</sub>	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	19.5	-	
Gate Resistance	Rg	f = 1 MHz	0.6	1.9	3.5	Ω
Turn-On Delay Time	t <sub>d(on)</sub>		-	8	16	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 100 V, $R_L$ = 33.3 $\Omega$	-	16	32	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 3$ A, $V_{GEN} = 10$ V, $R_g = 1$ $\Omega$	-	16	32	
Fall Time	t <sub>f</sub>		-	16	32	1
Turn-On Delay Time	t <sub>d(on)</sub>		-	10	20	ns
Rise Time	t <sub>r</sub>	$V_{DD} = 100 \text{ V}, \text{ R}_{L} = 33.3 \Omega$	-	17	34	-
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 3$ A, $V_{GEN} = 7.5$ V, $R_g = 1 \ \Omega$	-	14	28	
Fall Time	t <sub>f</sub>		-	16	32	
Drain-Source Body Diode Characteristic	s		•	•	•	
Continuous Source-Drain Diode Current	I <sub>S</sub>	$T_{C} = 25 \ ^{\circ}C$	-	-	14.1	
Pulse Diode Forward Current (t = 100 $\mu$ s)	I <sub>SM</sub>		-	-	30	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A	-	0.82	1.1	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	89	178	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 5 A, dl/dt = 100 A/μs,	-	258	516	nC
		$T_{\rm J} = 25 \ ^{\circ}{\rm C}$			-	
Reverse Recovery Rise Time	t <sub>b</sub>		-	17	-	ns

#### Notes

a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$ 

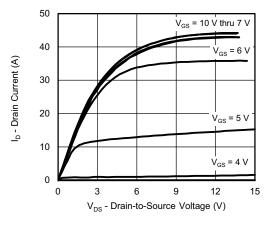
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

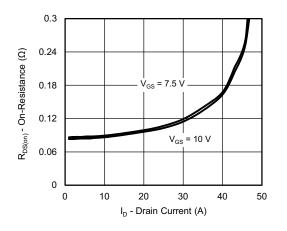
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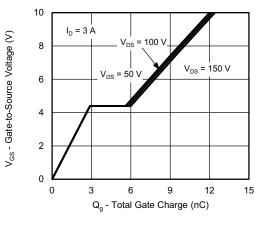
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



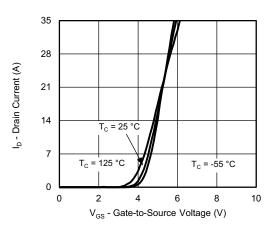
**Output Characteristics** 



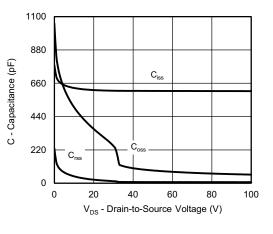
**On-Resistance vs. Drain Current** 



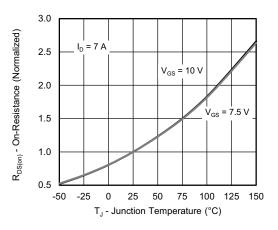
Gate Charge



**Transfer Characteristics** 



Capacitance



**On-Resistance vs. Junction Temperature** 

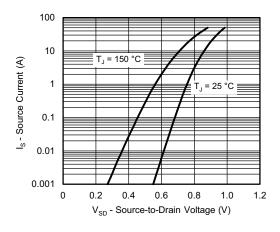
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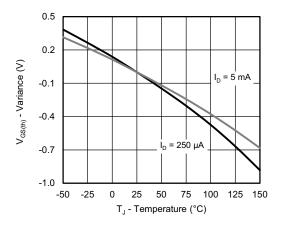
S16-0992-Rev. A, 23-May-16



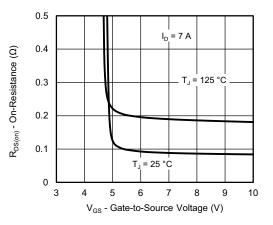
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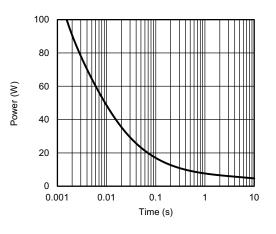
Source-Drain Diode Forward Voltage



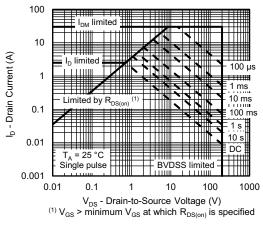
**Threshold Voltage** 



**On-Resistance vs. Gate-to-Source Voltage** 



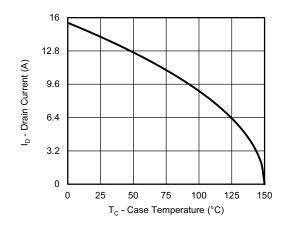
Single Pulse Power, Junction-to-Ambient



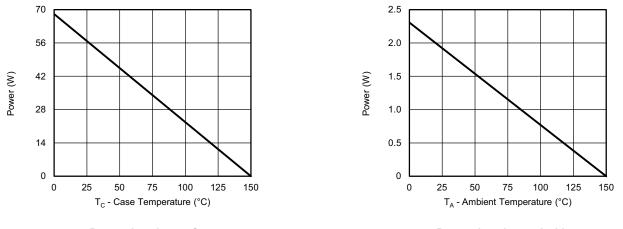
Safe Operating Area



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating a



Power, Junction-to-Case

Power, Junction-to-Ambient

#### Note

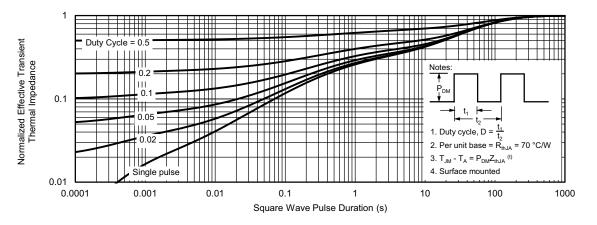
a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



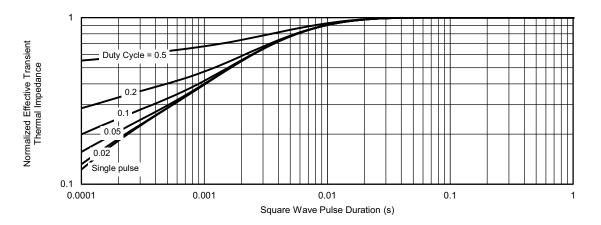
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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

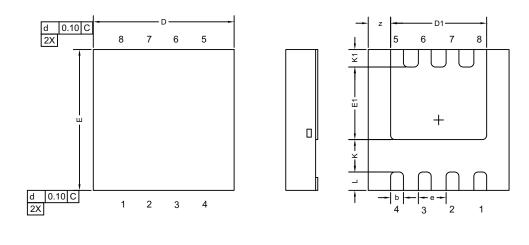


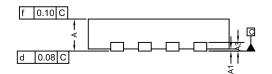
Normalized Thermal Transient Impedance, Junction-to-Case

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# Case Outline for PowerPAK® 1212-8S





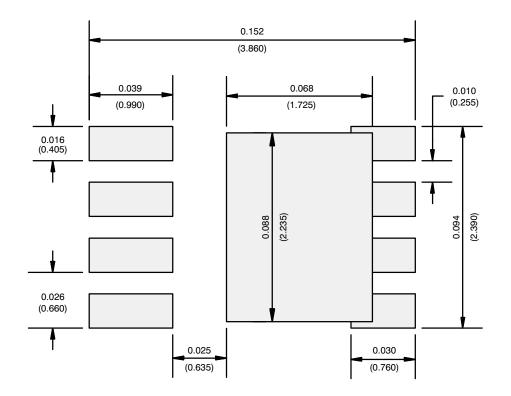
DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
А	0.67	0.75	0.83	0.027	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
A3	0.20 REF				0.008 REF		
b	0.30 BSC			0.012 BSC			
D	3.30 BSC			0.130 BSC			
D1	2.15	2.25	2.35	0.084	0.088	0.092	
E	3.30 BSC			0.130 BSC			
E1	1.60	1.70	1.80	0.063	0.067	0.071	
е	0.65 BSC			0.026 BSC			
К	0.76 TYP			0.030 TYP			
K1	0.41 TYP			0.016 TYP			
L	0.43 BSC			0.017 BSC			
Z	0.525 TYP			0.021 TYP			

Note

• Millimeters will govern.



## **RECOMMENDED MINIMUM PADS FOR PowerPAK® 1212-8 Single**



Recommended Minimum Pads Dimensions in Inches/(mm)

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